

# PCA9512A; PCA9512B

Level shifting hot swappable I<sup>2</sup>C-bus and SMBus bus buffer

Rev. 6 — 1 March 2013 Product data sheet

# 1. General description

The PCA9512A/B is a hot swappable I<sup>2</sup>C-bus and SMBus buffer that allows I/O card insertion into a live backplane without corruption of the data and clock buses and includes two dedicated supply voltage pins to provide level shifting between 3.3 V and 5 V systems while maintaining the best noise margin for each voltage level. Either pin may be powered with supply voltages ranging from 2.7 V to 5.5 V with no constraints on which supply voltage is higher. Control circuitry prevents the backplane from being connected to the card until a stop bit or bus idle occurs on the backplane without bus contention on the card. When the connection is made, the PCA9512A/B provides bidirectional buffering, keeping the backplane and card capacitances isolated.

Both the PCA9512A and PCA9512B use identical silicon (PCN201012007F dated 13 Dec 2010), so the PCA9512B will be discontinued in the near future and is not recommended for new designs.

The PCA9512A/B rise time accelerator circuitry allows the use of weaker DC pull-up currents while still meeting rise time requirements. The PCA9512A/B incorporates a digital input pin that enables and disables the rise time accelerators on all four SDAn and SCLn pins.

During insertion, the PCA9512A/B SDAn and SCLn pins are precharged to 1 V to minimize the current required to charge the parasitic capacitance of the chip.

The incremental offset design of the PCA9510A/11A/12A/12B/13A/14A I/O drivers allows them to be connected to another PCA9510A/11A/12A/12B/13A/14A device in series or in parallel and to the I<sup>2</sup>C compliant side of static offset bus buffers, but not to the static offset side of those bus buffers.

### 2. Features and benefits

- Bidirectional buffer for SDA and SCL lines increases fan-out and prevents SDA and SCL corruption during live board insertion and removal from multipoint backplane systems
- Compatible with I<sup>2</sup>C-bus Standard mode, I<sup>2</sup>C-bus Fast mode, and SMBus standards
- Built-in  $\Delta V/\Delta t$  rise time accelerators on all SDA and SCL lines (0.6 V threshold) with ability to disable  $\Delta V/\Delta t$  rise time accelerator through the ACC pin for lightly loaded systems, requires the bus pull-up voltage and respective supply voltage (V<sub>CC</sub> or V<sub>CC2</sub>) to be the same
- 5 V to 3.3 V level translation with optimum noise margin
- High-impedance SDAn and SCLn pins for V<sub>CC</sub> or V<sub>CC2</sub> = 0 V
- 1 V precharge on all SDAn and SCLn pins
- Supports clock stretching and multiple master arbitration and synchronization



- Operating power supply voltage range: 2.7 V to 5.5 V
- 0 Hz to 400 kHz clock frequency
- ESD protection exceeds 2000 V HBM per JESD22-A114 and 1000 V CDM per JESD22-C101
- Latch-up testing is done to JEDEC Standard JESD78 which exceeds 100 mA
- Packages offered: SO8, TSSOP8 (MSOP8)

# 3. Applications

 cPCI, VME, AdvancedTCA cards and other multipoint backplane cards that are required to be inserted or removed from an operating system

### 4. Feature selection

Table 1. Feature selection chart

Feature	PCA9510A	PCA9511A	PCA9512A/B	PCA9513A	PCA9514A
Idle detect	yes	yes	yes	yes	yes
High-impedance SDAn, SCLn pins for $V_{CC} = 0 \text{ V}$	yes	yes	yes	yes	yes
Rise time accelerator circuitry on SDAn and SCLn pins	-	yes	yes	yes	yes
Rise time accelerator circuitry hardware disable pin for lightly loaded systems	-	-	yes	-	-
Rise time accelerator threshold 0.8 V versus 0.6 V improves noise margin	-	-	-	yes	yes
Ready open-drain output	yes	yes	-	yes	yes
Two $V_{\text{CC}}$ pins to support 5 V to 3.3 V level translation with improved noise margins	-	-	yes	-	-
1 V precharge on all SDAn and SCLn pins	in only	yes	yes	-	-
$92~\mu\text{A}$ current source on SCLIN and SDAIN for PICMG applications	-	-	-	yes	-

# **Ordering information**

Table 2. **Ordering information** 

Type number	Topside	Package	<sup>p</sup> ackage								
	mark		Description								
PCA9512AD	PA9512A	SO8	plastic small outline package; 8 leads; body width 3.9 mm	SOT96-1							
PCA9512BD	PA9512B										
PCA9512ADP	9512A	TSSOP8[1]	plastic thin shrink small outline package; 8 leads; body width 3 mm	SOT505-1							
PCA9512BDP	9512B										

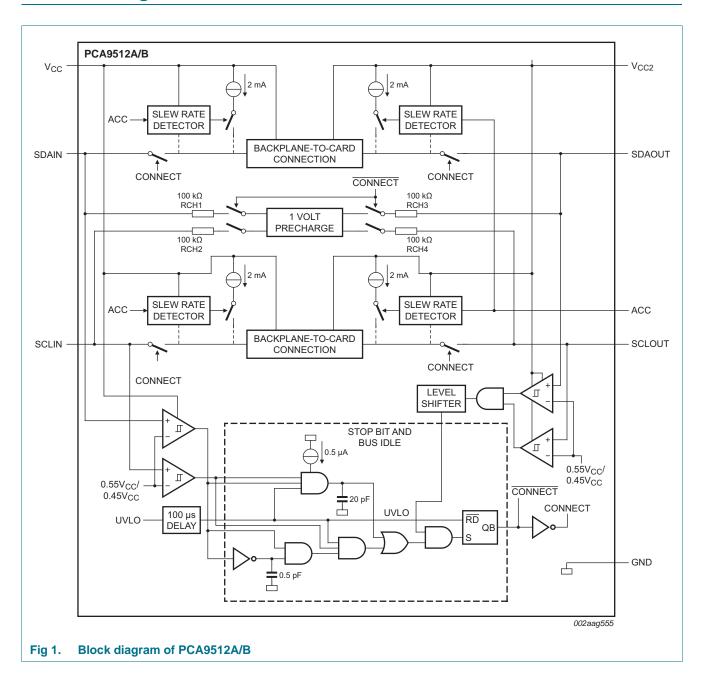
<sup>[1]</sup> Also known as MSOP8.

### **5.1 Ordering options**

Table 3. **Ordering options** 

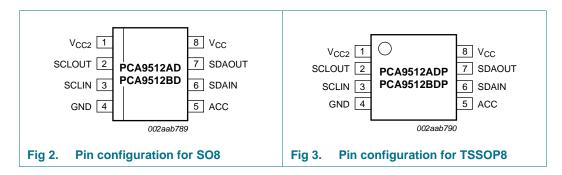
Type number	Orderable part number	Package	Packing method	Minimum order quantity	Temperature range
PCA9512AD	PCA9512AD,112	SO8	standard marking * IC's tube - DSC bulk pack	2000	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$
	PCA9512AD,118	SO8	reel 13" Q1/T1 *standard mark SMD	2500	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$
PCA9512BD	PCA9512BD,118	SO8	reel 13" Q1/T1 *standard mark SMD	2500	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$
PCA9512ADP	PCA9512ADP,118	TSSOP8	reel 13" Q1/T1 *standard mark SMD	2500	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$
PCA9512BDP	PCA9512BDP,118	TSSOP8	reel 13" Q1/T1 *standard mark SMD	2500	$T_{amb} = -40  ^{\circ}\text{C} \text{ to } +85  ^{\circ}\text{C}$

# 6. Block diagram



# 7. Pinning information

### 7.1 Pinning



### 7.2 Pin description

Table 4. Pin description

Symbol	Pin	Description
$V_{CC2}$	1	Supply voltage for devices on the card I <sup>2</sup> C-bus. Connect pull-up resistors from SDAOUT and SCLOUT to this pin.
SCLOUT	2	serial clock output to and from the SCL bus on the card
SCLIN	3	serial clock input to and from the SCL bus on the backplane
GND	4	ground supply; connect this pin to a ground plane for best results.
ACC	5	CMOS threshold digital input pin that enables and disables the rise time accelerators on all four SDAn and SCLn pins. ACC enables all accelerators when set to $V_{CC2}$ , and turns them off when set to GND.
SDAIN	6	serial data input to and from the SDA bus on the backplane
SDAOUT	7	serial data output to and from the SDA bus on the card
$V_{CC}$	8	supply voltage; from the backplane, connect pull-up resistors from SDAIN and SCLIN to this pin.

# 8. Functional description

Refer to Figure 1 "Block diagram of PCA9512A/B".

Both the PCA9512A and PCA9512B use identical silicon (PCN201012007F dated 13 Dec 2010), so the PCA9512B will be discontinued in the near future and is not recommended for new designs. Customers should continue using the PCA9512A or move to the PCA9512A during the next refresh if they are currently using the PCA9512B. Description of the PCA9512A operation applies equally to the PCA9512B for the remainder of this data sheet.

### 8.1 Start-up

When the PCA9512A is powered up, either  $V_{CC}$  or  $V_{CC2}$  may rise first, within a short time of each other and either may be more positive or they may be equal, however the PCA9512A will not leave the undervoltage lockout or initialization state until both  $V_{CC}$  and  $V_{CC2}$  have gone above 2.5 V. If either  $V_{CC}$  or  $V_{CC2}$  drops below 2.0 V it will return to the undervoltage lockout state.

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In the undervoltage lockout state the connection circuitry is disabled, the rise time accelerators are disabled, and the precharge circuitry is also disabled. After both  $V_{CC}$  and  $V_{CC2}$  are valid, independent of which is higher, the PCA9512A/B enters the initialization state; during this state the 1 V precharge circuitry is activated and pulls up the SDAn and SCLn pins to 1 V through individual 100  $k\Omega$  nominal resistors. At the end of the initialization state the 'Stop bit and bus idle' detect circuit is enabled. When all the SDAn and SCLn pins have been HIGH for the bus idle time or when all pins are HIGH and a STOP condition is seen on the SDAIN and SCLIN pins, the connect circuitry is activated, connecting SDAIN to SDAOUT and SCLIN to SCLOUT. The 1 V precharge circuitry is disabled when the connection is made, unless the ACC pin is LOW; the rise time accelerators are enabled at this time also.

### 8.2 Connect circuitry

Once the connection circuitry is activated, the behavior of SDAIN and SDAOUT as well as SCLIN and SCLOUT become identical, with each acting as a bidirectional buffer that isolates the input bus capacitance from the output bus capacitance while communicating. If  $V_{CC} \neq V_{CC2}$ , then a level shifting function is performed between input and output. A LOW forced on either SDAIN or SDAOUT will cause the other pin to be driven to a LOW by the PCA9512A/B. The same is also true for the SCLn pins. Noise between  $0.7V_{CC}$  and  $V_{CC}$ on the SDAIN and SCLIN pins, and  $0.7V_{CC2}$  and  $V_{CC2}$  on the SDAOUT and SCLOUT pins is generally ignored because a falling edge is only recognized when it falls below 0.7V<sub>CC</sub> for SDAIN and SCLIN (or 0.7V<sub>CC2</sub> for SDAOUT and SCLOUT pins) with a slew rate of at least 1.25 V/µs. When a falling edge is seen on one pin, the other pin in the pair turns on a pull-down driver that is referenced to a small voltage above the falling pin. The driver will pull the pin down at a slew rate determined by the driver and the load. The first falling pin may have a fast or slow slew rate; if it is faster than the pull-down slew rate, then the initial pull-down rate will continue until it is LOW. If the first falling pin has a slow slew rate, then the second pin will be pulled down at its initial slew rate only until it is just above the first pin voltage then they will both continue down at the slew rate of the first.

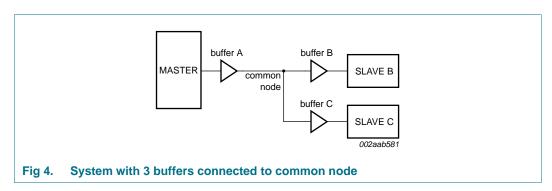
Once both sides are LOW they will remain LOW until all the external drivers have stopped driving LOWs. If both sides are being driven LOW to the same (or nearly the same) value by external drivers, which is the case for clock stretching and is typically the case for acknowledge, and one side external driver stops driving, that pin will rise and rise above the nominal offset voltage until the internal driver catches up and pulls it back down to the offset voltage. This bounce is worst for low capacitances and low resistances, and may become excessive. When the last external driver stops driving a LOW, that pin will bounce up and settle out just above the other pin as both rise together with a slew rate determined by the internal slew rate control and the RC time constant. As long as the slew rate is at least 1.25 V/ $\mu$ s, when the pin voltage exceeds 0.6 V, the rise time accelerator circuits are turned on and the pull-down driver is turned off. If the ACC pin is LOW, the rise time accelerator circuits will be disabled, but the pull-down driver will still turn off.

### 8.3 Maximum number of devices in series

Each buffer adds about 0.1 V dynamic level offset at 25 °C with the offset larger at higher temperatures. Maximum offset ( $V_{offset}$ ) is 0.150 V with a 10 k $\Omega$  pull-up resistor. The LOW level at the signal origination end (master) is dependent upon the load and the only specification point is the I²C-bus specification of 3 mA will produce  $V_{OL} < 0.4$  V, although if lightly loaded the  $V_{OL}$  may be ~0.1 V. Assuming  $V_{OL} = 0.1$  V and  $V_{offset} = 0.1$  V, the level after four buffers would be 0.5 V, which is only about 0.1 V below the threshold of the

rising edge accelerator (about 0.6 V). With great care a system with four buffers may work, but as the  $V_{OL}$  moves up from 0.1 V, noise or bounces on the line will result in firing the rising edge accelerator thus introducing false clock edges. Generally it is recommended to limit the number of buffers in series to two, and to keep the load light to minimize the offset.

The PCA9510A (rise time accelerator is permanently disabled) and the PCA9512A (rise time accelerator can be turned off) are a little different with the rise time accelerator turned off because the rise time accelerator will not pull the node up, but the same logic that turns on the accelerator turns the pull-down off. If the  $V_{\rm IL}$  is above ~0.6 V and a rising edge is detected, the pull-down will turn off and will not turn back on until a falling edge is detected.



Consider a system with three buffers connected to a common node and communication between the Master and Slave B that are connected at either end of buffer A and buffer B in series as shown in Figure 4. Consider if the V<sub>OL</sub> at the input of buffer A is 0.3 V and the  $V_{\text{OL}}$  of Slave B (when acknowledging) is 0.4 V with the direction changing from Master to Slave B and then from Slave B to Master. Before the direction change you would observe V<sub>II</sub> at the input of buffer A of 0.3 V and its output, the common node, is ~0.4 V. The output of buffer B and buffer C would be ~0.5 V, but Slave B is driving 0.4 V, so the voltage at Slave B is 0.4 V. The output of buffer C is ~0.5 V. When the Master pull-down turns off, the input of buffer A rises and so does its output, the common node, because it is the only part driving the node. The common node will rise to 0.5 V before buffer B's output turns on, if the pull-up is strong the node may bounce. If the bounce goes above the threshold for the rising edge accelerator ~0.6 V the accelerators on both buffer A and buffer C will fire contending with the output of buffer B. The node on the input of buffer A will go HIGH as will the input node of buffer C. After the common node voltage is stable for a while the rising edge accelerators will turn off and the common node will return to ~0.5 V because the buffer B is still on. The voltage at both the Master and Slave C nodes would then fall to ~0.6 V until Slave B turned off. This would not cause a failure on the data line as long as the return to 0.5 V on the common node (~0.6 V at the Master and Slave C) occurred before the data setup time. If this were the SCL line, the parts on buffer A and buffer C would see a false clock rather than a stretched clock, which would cause a system error.

### 8.4 Propagation delays

The delay for a rising edge is determined by the combined pull-up current from the bus resistors and the rise time accelerator current source and the effective capacitance on the lines. If the pull-up currents are the same, any difference in rise time is directly proportional to the difference in capacitance between the two sides. The  $t_{PLH}$  may be negative if the output capacitance is less than the input capacitance and would be positive if the output capacitance is larger than the input capacitance, when the currents are the same.

The  $t_{PHL}$  can never be negative because the output does not start to fall until the input is below  $0.7V_{CC}$  (or  $0.7V_{CC2}$  for SDAOUT and SCLOUT), and the output turn-ON has a non-zero delay, and the output has a limited maximum slew rate, and even if the input slew rate is slow enough that the output catches up it will still lag the falling voltage of the input by the offset voltage. The maximum  $t_{PHL}$  occurs when the input is driven LOW with zero delay and the output is still limited by its turn-on delay and the falling edge slew rate. The output falling edge slew rate is a function of the internal maximum slew rate which is a function of temperature,  $V_{CC}$  or  $V_{CC2}$  and process, as well as the load current and the load capacitance.

### 8.5 Rise time accelerators

During positive bus transactions, a 2 mA current source is switched on to quickly slew the SDA and SCL lines HIGH once the input level of 0.6 V for the PCA9512A is exceeded. The rising edge rate should be at least 1.25 V/ $\mu$ s to guarantee turn on of the accelerators. The built-in  $\Delta$ V/ $\Delta$ t rise time accelerators on all SDA and SCL lines requires the bus pull-up voltage and respective supply voltage (V<sub>CC</sub> or V<sub>CC2</sub>) to be the same. The built-in  $\Delta$ V/ $\Delta$ t rise time accelerators can be disabled through the ACC pin for lightly loaded systems.

### 8.6 ACC boost current enable

Users having lightly loaded systems may wish to disable the rise time accelerators. Driving this pin to ground turns off the rise time accelerators on all four SDAn and SCLn pins. Driving this pin to the  $V_{CC2}$  voltage enables normal operation of the rise time accelerators.

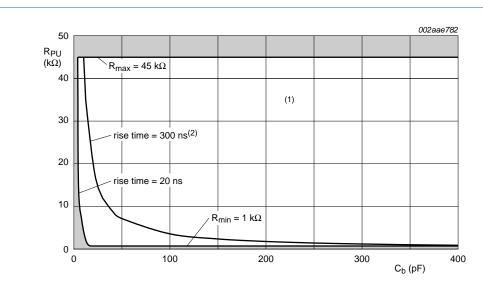
### 8.7 Resistor pull-up value selection

The system pull-up resistors must be strong enough to provide a positive slew rate of 1.25 V/ $\mu$ s on the SDAn and SCLn pins, in order to activate the boost pull-up currents during rising edges. Choose maximum resistor value using the formula given in Equation 1:

$$R_{PU} \le 800 \times 10^3 \left(\frac{V_{CC(min)} - 0.6}{C}\right)$$
 (1)

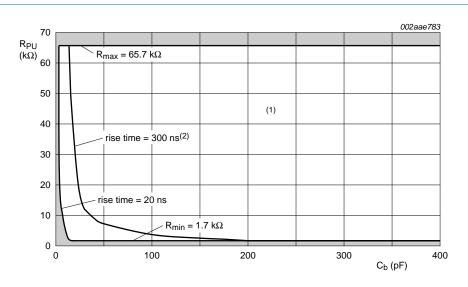
where  $R_{PU}$  is the pull-up resistor value in  $\Omega$ ,  $V_{CC(min)}$  is the minimum  $V_{CC}$  voltage in volts, and C is the equivalent bus capacitance in picofarads.

In addition, regardless of the bus capacitance, always choose  $R_{PU} \leq 65.7~k\Omega$  for  $V_{CC} = 5.5~V$  maximum,  $R_{PU} \leq 45~k\Omega$  for  $V_{CC} = 3.6~V$  maximum. The start-up circuitry requires logic HIGH voltages on SDAOUT and SCLOUT to connect the backplane to the card, and these pull-up values are needed to overcome the precharge voltage. See the curves in Figure 5 and Figure 6 for guidance in resistor pull-up selection.



- (1) Unshaded area indicates recommended pull-up, for rise time < 300 ns, with rise time accelerator turned on.
- (2) Rise time accelerator off.

Fig 5. Bus requirements for 3.3 V systems



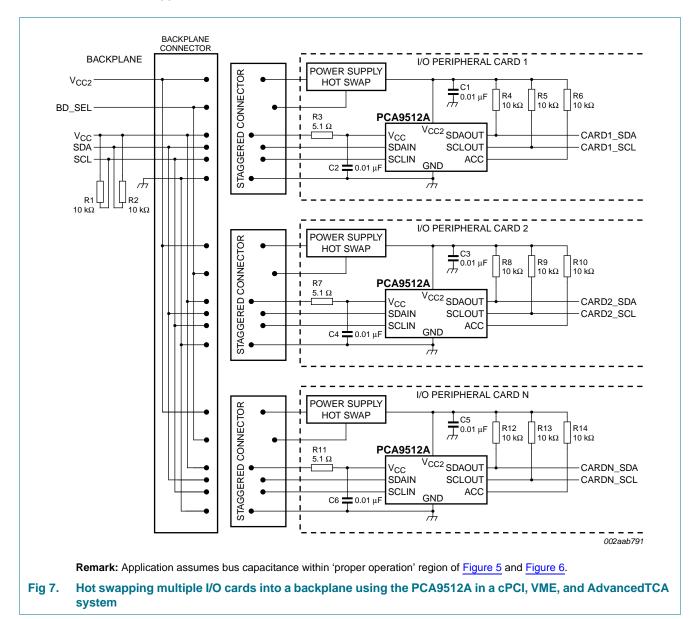
- (1) Unshaded area indicates recommended pull-up, for rise time < 300 ns, with rise time accelerator turned on.
- (2) Rise time accelerator off.

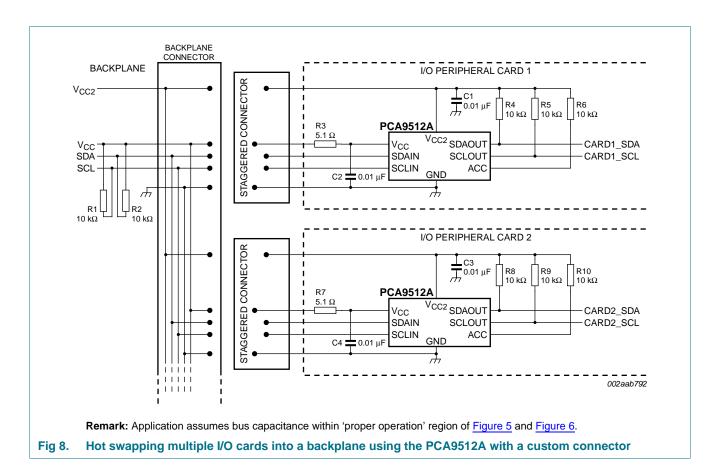
Fig 6. Bus requirements for 5 V systems

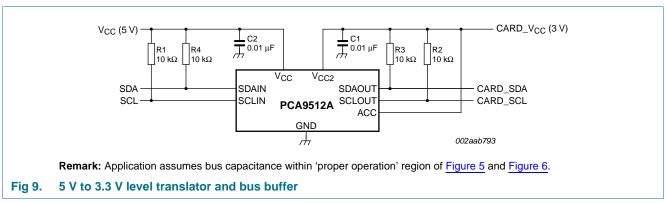
### 8.8 Hot swapping and capacitance buffering application

<u>Figure 7</u> through <u>Figure 9</u> illustrate the usage of the PCA9512A in applications that take advantage of both its hot swapping and capacitance buffering features. In all of these applications, note that if the I/O cards were plugged directly into the backplane, all of the backplane and card capacitances would add directly together, making rise time and fall time requirements difficult to meet. Placing a bus buffer on the edge of each card, however, isolates the card capacitance from the backplane. For a given I/O card, the PCA9512A drives the capacitance of everything on the card and the backplane must drive only the capacitance of the bus buffer, which is less than 10 pF, the connector, trace, and all additional cards on the backplane.

See *Application Note AN10160, 'Hot Swap Bus Buffer'* for more information on applications and technical assistance.







### 8.9 Voltage level translator discussion

### 8.9.1 Summary

There are two popular configurations for the interface of low voltage logic (i.e., core processor with 3.3 V supply) to standard bus levels (i.e., I<sup>2</sup>C-bus with 5 V supply). A single FET transistor and two additional resistors may be used effectively, or an application-specific IC part requiring no external components and no additional resistors.

The FET solution becomes problematic as the low voltage logic levels trend downwards. The FET solution will stop working completely when the FET specification is no longer matched to the LOW level logic supply voltage requirements.

The dominant advantage of the FET solution is cost, but the IC part provides additional advantages to the design, which increases reliability to the end user.

### 8.9.2 Why do level translation?

Advances in processing technology require lower supply voltages, due to reduced clearances in the fabrication technology. Lower supply voltages drive down signal swings, or require that on die high voltage I/O sections are added, creating larger die area, or greater I/O pin count. Existing standards for interoperability of equipment connected by cables or between subsystems require higher voltage signal swings (typically 5 V).

An external voltage level translator solves these problems, but requires additional parts.

### 8.10 Limitations of the FET voltage level translator

### 8.10.1 V<sub>GSth</sub>, gate-source threshold voltage

When the VA input is logic LOW, the FET is turned on, pulling VB output LOW. This can only occur when the threshold voltage of the FET is less than the VA supply voltage minus the maximum level of the VA signal, VAIL. Using CMOS logic thresholds of 0.3 and 0.7 times the supply, and a 1.1 V VA gives a worst-case of just 330 mV, much less than  $V_{GSth}$  of the popular 2N7002 FET.

$$V_{GSth}$$
;  $I_D = 250 \mu A$ ;  $V_{DS} = V_{GS}$ ; 1.1 V (min.)/1.6 V (typ.)/2.1 V (max.)

Additionally, the FET threshold voltage is specified in the linear region of the FET, with weak conduction. Ideally the FET should have very low ON-resistance. For the 2N7002, this is specified at 5 V  $V_{GS}$  (not the 1 V available in this application). Note that the ON-resistance decreases rapidly as  $V_{GS}$  is increased beyond the  $V_{GSth}$  specification. Unintended operation in the linear region further compromises logic level noise immunity.

### 8.10.2 FET body diode voltage

The FET is required to conduct in both directions, as the I2C-bus is bidirectional. When the VB input is logic LOW, the body diode of the FET conducts first, pulling the FET source LOW along with the FET drain, until the FET conducts. During this transition the forward voltage drop of the body diode reduces the available FET gain to source bias. The body diode is specified:

 $V_{SD}$ , source-drain voltage;  $I_S$  = 115 mA;  $V_{GS}$  = 0 V; 0.47 V (min.)/0.75 V (typ.)/1.1 V (max.)

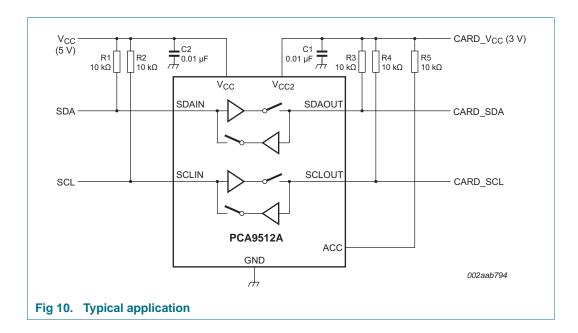
Conduction of the FET body diode impacts both the delay time and logic transition speed.

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### 8.11 Additional system compromises

- Additional parts
- · Additional assembly cost
- · Reduced system reliability due to complexity
- Reduced logic level noise margin (immunity)
- · Sensitivity to ground offsets between sub-systems (cable links, for example)
- Increased loading on the low voltage side (must carry the high voltage side sink current)
- ESD robustness

# 9. Application design-in information



# 10. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+7	V
$V_{CC2}$	supply voltage 2 <sup>[1]</sup>		-0.5	+7	V
V <sub>n</sub>	voltage on any other pin		-0.5	+7	V
I <sub>I</sub>	input current		[2] -	±20	mA
I <sub>I/O</sub>	input/output current		<u>[3]</u> _	±50	mA
T <sub>oper</sub>	operating temperature		-40	+85	°C
T <sub>stg</sub>	storage temperature		-65	+125	°C
T <sub>sp</sub>	solder point temperature	10 s maximum	-	300	°C
T <sub>j(max)</sub>	maximum junction temperature		-	125	°C

<sup>[1]</sup> Card side supply voltage.

### 11. Characteristics

Table 6. Characteristics

 $V_{\rm CC}$  = 2.7 V to 5.5 V;  $T_{\rm amb}$  = -40 °C to +85 °C; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Power suppl	у						
V <sub>CC</sub>	supply voltage		[1]	2.7	-	5.5	V
V <sub>CC2</sub>	supply voltage 2[2]		[1]	2.7	-	5.5	V
I <sub>CC</sub>	supply current	$V_{CC} = 5.5 \text{ V};$ $V_{SDAIN} = V_{SCLIN} = 0 \text{ V}$		-	1.8	3.6	mA
I <sub>CC2</sub>	supply current 2	$V_{CC} = 5.5 \text{ V};$ $V_{SDAOUT} = V_{SCLOUT} = 0 \text{ V}$		-	1.7	2.9	mA
Start-up circ	uitry						
V <sub>pch</sub>	precharge voltage	SDA, SCL floating	[1]	0.8	1.1	1.2	V
t <sub>en</sub>	enable time	on power-up	[3]	-	180	-	μS
t <sub>idle</sub>	idle time		[1][4]	50	140	250	μS
Rise time acc	celerators						
I <sub>trt(pu)</sub>	transient boosted pull-up current	positive transition on SDA, SCL; $V_{ACC}$ = 0.7 × $V_{CC2}$ ; $V_{CC}$ = 2.7 V; slew rate = 1.25 V/ $\mu$ s	<u>[5][6]</u>	1	2	-	mA
V <sub>th(dis)(ACC)</sub>	disable threshold voltage on pin ACC			0.3V <sub>CC2</sub>	0.5V <sub>CC2</sub>	-	V
V <sub>th(en)(ACC)</sub>	enable threshold voltage on pin ACC			-	0.5V <sub>CC2</sub>	0.7V <sub>CC2</sub>	V
I <sub>I(ACC)</sub>	input current on pin ACC			-1	±0.1	+1	μΑ
t <sub>PD(on/off)(ACC)</sub>	on/off propagation delay on pin ACC			-	5	-	ns

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<sup>[2]</sup> Maximum current for inputs.

<sup>[3]</sup> Maximum current for I/O pins.

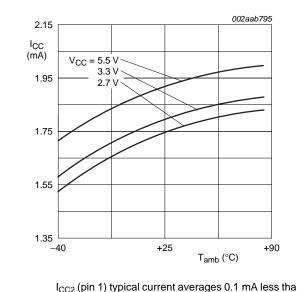
Table 6. Characteristics ... continued

 $V_{CC}$  = 2.7 V to 5.5 V;  $T_{amb}$  = -40 °C to +85 °C; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Input-output	ut connection						
V <sub>offset</sub>	offset voltage	10 k $\Omega$ to V <sub>CC</sub> on SDA, SCL; V <sub>CC</sub> = 3.3 V; V <sub>CC2</sub> = 3.3 V; V <sub>I</sub> = 0.2 V	[1][7]	0	115	175	mV
C <sub>i</sub>	input capacitance	digital; guaranteed by design, not subject to test		-	-	10	pF
V <sub>OL</sub>	LOW-level output voltage	$V_{l}$ = 0 V; SDAn, SCLn pins; $I_{sink}$ = 3 mA; $V_{CC}$ = 2.7 V; $V_{CC2}$ = 2.7 V	[1]	0	0.3	0.4	V
I <sub>LI</sub>	input leakage current	SDAn, SCLn pins; $V_{CC} = 5.5 \text{ V}$ ; $V_{CC2} = 5.5 \text{ V}$		<b>-1</b>	-	+1	μА
System ch	aracteristics						
f <sub>SCL</sub>	SCL clock frequency		[8]	0	-	400	kHz
t <sub>BUF</sub>	bus free time between a STOP and START condition		[8]	1.3	-	-	μS
t <sub>HD;STA</sub>	hold time (repeated) START condition		[8]	0.6	-	-	μS
t <sub>SU;STA</sub>	set-up time for a repeated START condition		[8]	0.6	-	-	μS
t <sub>SU;STO</sub>	set-up time for STOP condition		[8]	0.6	-	-	μS
t <sub>HD;DAT</sub>	data hold time		[8]	300	-	-	ns
t <sub>SU;DAT</sub>	data set-up time		[8]	100	-	-	ns
t <sub>LOW</sub>	LOW period of the SCL clock		[8]	1.3	-	-	μS
t <sub>HIGH</sub>	HIGH period of the SCL clock		[8]	0.6	-	-	μS
t <sub>f</sub>	fall time of both SDA and SCL signals		[8][9]	20 + 0.1 × C <sub>b</sub>	-	300	ns
t <sub>r</sub>	rise time of both SDA and SCL signals		[8][9]	$20 + 0.1 \times C_b$	-	300	ns

- [1] This specification applies over the full operating temperature range.
- [2] Card side supply voltage.
- [3] The enable time is from power-up of  $V_{CC}$  and  $V_{CC2} \ge 2.7$  V to when idle or stop time begins.
- [4] Idle time is from when SDAn and SCLn are HIGH after enable time has been met.
- [5] Itrt(pu) varies with temperature and V<sub>CC</sub> voltage, as shown in Section 11.1 "Typical performance characteristics".
- [6] Input pull-up voltage should not exceed power supply voltage in operating mode because the rise time accelerator will clamp the voltage to the positive supply rail.
- [7] The connection circuitry always regulates its output to a higher voltage than its input. The magnitude of this offset voltage as a function of the pull-up resistor and V<sub>CC</sub> voltage is shown in Section 11.1 "Typical performance characteristics".
- [8] Guaranteed by design, not production tested.
- [9] C<sub>b</sub> = total capacitance of one bus line in pF.

# 11.1 Typical performance characteristics



 $I_{CC2}$  (pin 1) typical current averages 0.1 mA less than  $I_{CC}$  on pin 8.

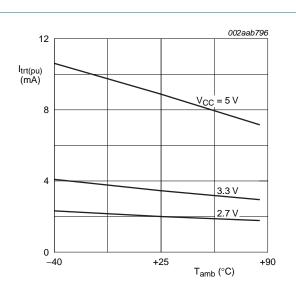


Fig 12. I<sub>trt(pu)</sub> versus temperature

Fig 11. I<sub>CC</sub> versus temperature

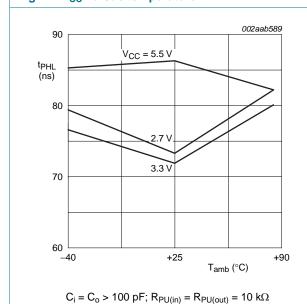


Fig 13. Input/output t<sub>PHL</sub> versus temperature

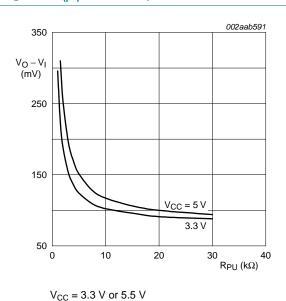
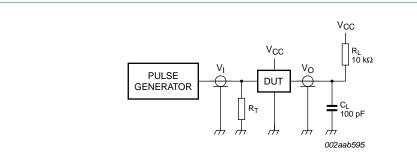


Fig 14. Connection circuitry V<sub>O</sub> – V<sub>I</sub>

# 12. Test information



R<sub>L</sub> = load resistor

 $C_L$  = load capacitance includes jig and probe capacitance

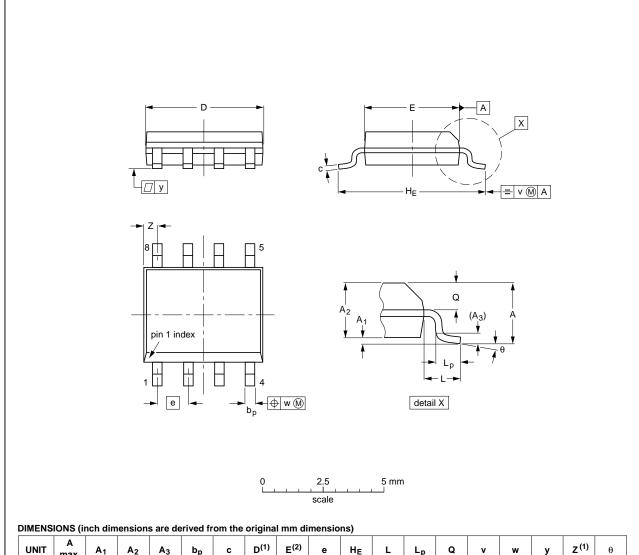
 $R_T$  = termination resistance should be equal to the output impedance  $Z_o$  of the pulse generator

Fig 15. Test circuitry for switching times

# 13. Package outline

### SO8: plastic small outline package; 8 leads; body width 3.9 mm

SOT96-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	σ	٧	w	у	z <sup>(1)</sup>	θ
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	6.2 5.8	1.05	1.0 0.4	0.7 0.6	0.25	0.25	0.1	0.7 0.3	8°
inches	0.069	0.010 0.004	0.057 0.049	0.01		0.0100 0.0075	0.20 0.19	0.16 0.15	0.05	0.244 0.228	0.041	0.039 0.016	0.028 0.024	0.01	0.01	0.004	0.028 0.012	0°

### Notes

- 1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm (0.01 inch) maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT96-1	076E03	MS-012				<del>99-12-27</del> 03-02-18
001001	070200	WIG 012				(

### Fig 16. Package outline SOT96-1 (SO8)

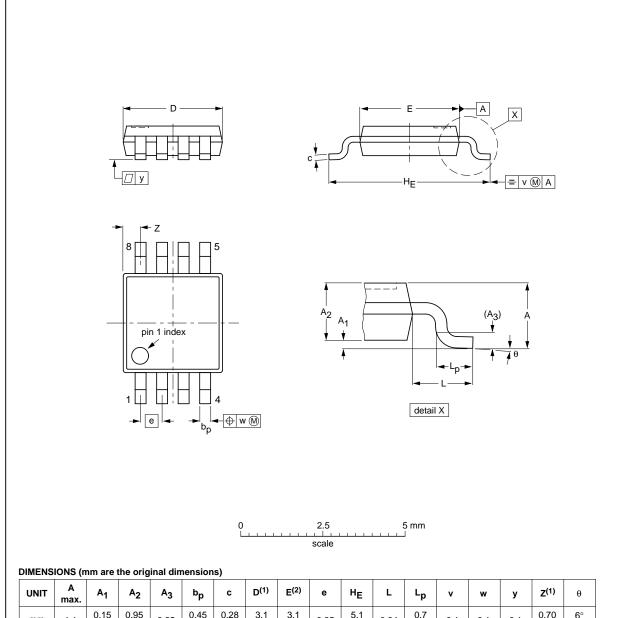
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TSSOP8: plastic thin shrink small outline package; 8 leads; body width 3 mm

SOT505-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	C	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	v	w	у	Z <sup>(1)</sup>	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.45 0.25	0.28 0.15	3.1 2.9	3.1 2.9	0.65	5.1 4.7	0.94	0.7 0.4	0.1	0.1	0.1	0.70 0.35	6° 0°

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

	REFER	EUROPEAN	ISSUE DATE		
IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
					<del>-99-04-09-</del> 03-02-18
	IEC				IEC JEDEC JEITA PROJECTION

Fig 17. Package outline SOT505-1 (TSSOP8)

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# 14. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365* "Surface mount reflow soldering description".

### 14.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

### 14.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- · Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- · Board specifications, including the board finish, solder masks and vias
- · Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

### 14.3 Wave soldering

Key characteristics in wave soldering are:

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

### 14.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 18</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 7 and 8

Table 7. SnPb eutectic process (from J-STD-020D)

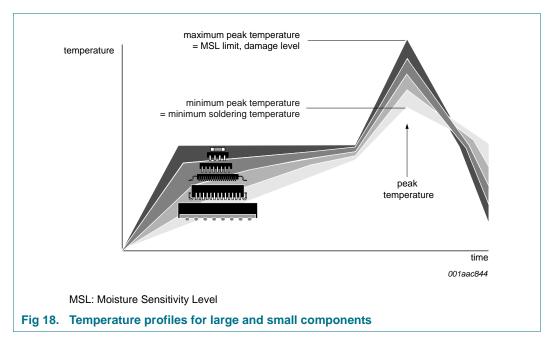
Package thickness (mm)	Package reflow temperature (°C)					
	Volume (mm <sup>3</sup> )					
	< 350	≥ 350				
< 2.5	235	220				
≥ 2.5	220	220				

Table 8. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)			
	Volume (mm³)			
	< 350	350 to 2000	> 2000	
< 1.6	260	260	260	
1.6 to 2.5	260	250	245	
> 2.5	250	245	245	

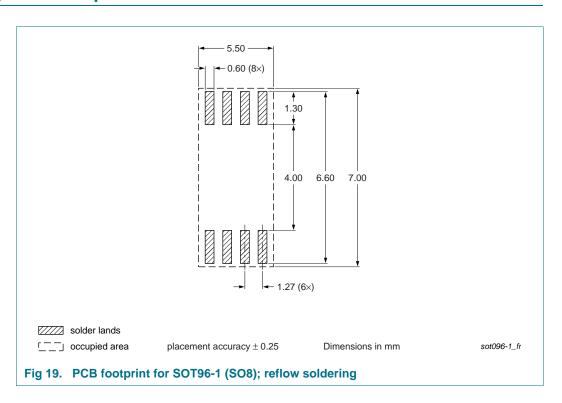
Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

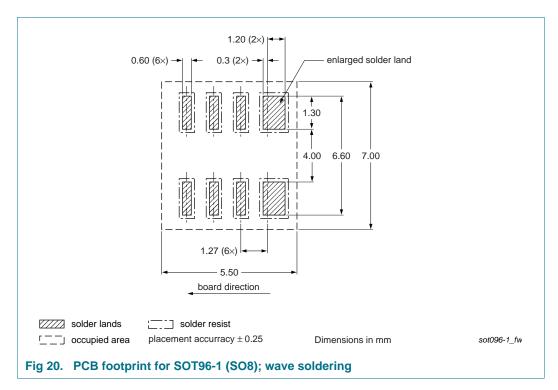
Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 18.

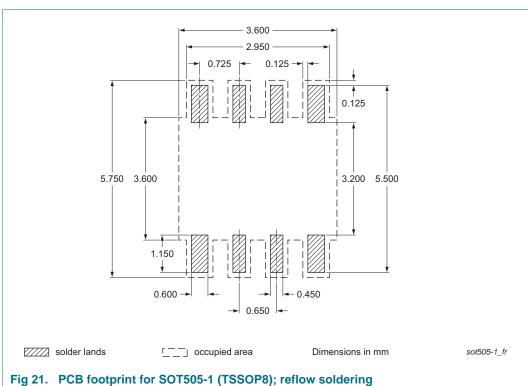


For further information on temperature profiles, refer to Application Note *AN10365* "Surface mount reflow soldering description".

# 15. Soldering: PCB footprints







# 16. Abbreviations

Table 9. Abbreviations

Table 0. Abbit	, vidiono
Acronym	Description
AdvancedTCA	Advanced Telecommunications Computing Architecture
AVL	Approved Vendor List
CDM	Charged-Device Model
CMOS	Complementary Metal-Oxide Semiconductor
cPCI	compact Peripheral Component Interface
ESD	Electrostatic Discharge
FET	Field-Effect Transistor
HBM	Human Body Model
I <sup>2</sup> C-bus	Inter-Integrated Circuit bus
IC	Integrated Circuit
PCI	Peripheral Component Interface
PICMG	PCI Industrial Computer Manufacturers Group
SMBus	System Management Bus
VME	VERSAModule Eurocard

# 17. Revision history

Table 10. Revision history

				_
Document ID	Release date	Data sheet status	Change notice	Supersedes
PCA9512A_PCA9512B v.6	20130301	Product data sheet	-	PCA9512A_PCA9512B v.5
Modifications:	Section 1 "G	General description": seco	ond paragraph re-writte	en
	<ul> <li>Section 2 "F JESD22-A1"</li> </ul>	eatures and benefits": 11 15"	th bullet item: deleted	"200 V MM per
	<ul> <li>Added <u>Section</u></li> </ul>	on 5.1 "Ordering options	<u>"</u>	
	<ul> <li>Figure 1 "Ble</li> </ul>	ock diagram of PCA9512	<u>A/B"</u> : added "LEVEL S	SHIFTER" block
	<ul> <li>Section 8 "F</li> </ul>	unctional description": ac	dded (new) second pa	ragraph
	<ul> <li>Figure 10 "T "PCA9512A</li> </ul>	ypical application": chan	ged type number from	"PCA9512A/B" to
	<ul> <li>Added <u>Section</u></li> </ul>	on 8.9 "Voltage level tran	nslator discussion"	
	<ul> <li>Added Section 8.10 "Limitations of the FET voltage level translator"</li> </ul>			
	<ul> <li>Added <u>Section</u></li> </ul>	on 8.11 "Additional syste	em compromises"	
	<ul> <li>Added <u>Section</u></li> </ul>	ion 15 "Soldering: PCB fo	ootprints"	
PCA9512A_PCA9512B v.5	20110105	Product data sheet	-	PCA9512A v.4
PCA9512A v.4	20090819	Product data sheet	-	PCA9512A v.3
PCA9512A v.3	20090720	Product data sheet	-	PCA9512A v.2
PCA9512A v.2	20090528	Product data sheet	-	PCA9512A v.1
PCA9512A v.1	20051007	Product data sheet	-	-

# 18. Legal information

### 18.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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# PCA9512A; PCA9512B

### Level shifting hot swappable I<sup>2</sup>C-bus and SMBus bus buffer

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Product data sheet

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